Issue Classification

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/EDNA WONG/

(Primary Examiner)

ORIGINAL

Application/Control No.	Applicant(s)/Patent Under Reexamination								
09996120	CHAN ET AL.								
Examiner	Art Unit								
EDNA WONG	1795								

INTERNATIONAL CLASSIFICATION

CLASS SI			SUBCLASS		CLAIMED						NON-CLAIMED					
205 413				С	2	5	С	1 / 00 (2006.01	.01)							
CROSS REFERENCE(S)			6)		С	2	5	В	3 / 00 (2006.01	.01)						
	CN	OSS REFI	EKENCE	3)												
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)																
205	343	427	455													
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NONE						Total Claims Allowed:						Allowed:				
(Assistant E	Examiner)		21							1						

U.S. Patent and Trademark Office Part of Paper No. 20080412

4/12/08

(Date)

O.G. Print Claim(s)

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O.G. Print Figure

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